



SGS-THOMSON
MICROELECTRONICS

THDT6511D

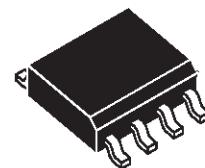
Application Specific Discretes
A.S.D.TM

TRANSIENT VOLTAGE SUPPRESSOR
FOR SLIC PROTECTION

PRELIMINARY DATASHEET

FEATURES

- DUAL ASYMETRICAL TRANSIENT SUPPRESSOR
- PEAK PULSE CURRENT : $I_{PP} = 40A$, 10/100 μ s
- HOLDING CURRENT : 150 mA min.
- BREAKDOWN VOLTAGE : 65 V min.
- LOW DYNAMIC CHARACTERISTICS
- STAND CCITT K20 AND LSSGR



SO8

DESCRIPTION

This device has been especially designed to protect subscriber line cards against overvoltage.

Two diodes clamp positive overloads while negative surges are suppressed by two protection thyristors.

A particular attention has been given to the internal wire bonding. The "4-point" configuration ensures a reliable protection, eliminating overvoltages introduced by the parasitic inductances of the wiring (Ldi/dt), especially for very fast transient overvoltages.

COMPLIES WITH THE FOLLOWING STANDARDS :

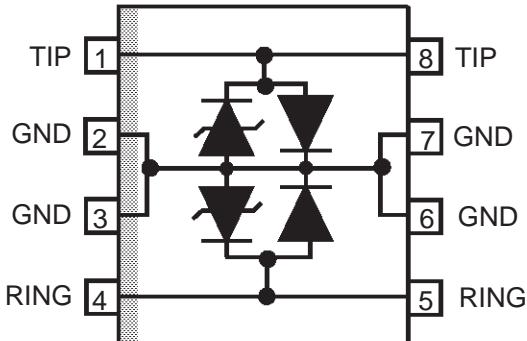
CCITT K20 :	10/700 μ s	1kV
	5/310 μ s	38A
VDE 0433 :	10/700 μ s	2kV
	5/310 μ s	50A
VDE 0878 :	1.2/50 μ s	1.5kV
	1/20 μ s	40A
I3124 :	0.5/700 μ s	1kV
	0.2/310 μ s	38A
FCC part 68 :	2/10 μ s	2.5kV
	2/10 μ s	125A (*)

BELLCORE

TR-NWT-001089 :	2/10 μ s	2.5kV
	2/10 μ s	125A (*)
	10/1000 μ s	1kV
	10/1000 μ s	40A (*)

(*) with series resistors or PTC.

SCHEMATIC DIAGRAM



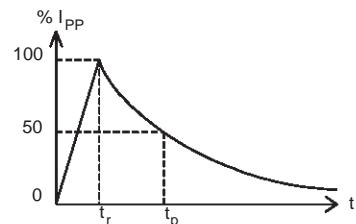
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ABSOLUTE MAXIMUM RATINGS ($T_{amb} = 25^\circ C$)

Symbol	Parameter	Value	Unit	
I_{PP}	Peak pulse current (see note 1)	10/1000μs 5/310μs 2/10μs	40 50 125	A
I_{TSM}	Non repetitive surge peak on-state current $F = 50$ Hz	$t = 300$ ms $t = 1$ s $t = 5$ s	10 3.5 1	A
I_{TSM}	$F = 50$ Hz, 60×1 s, 2 mn between pulse	1	A	
T_{stg} T_j	Storage temperature range Maximum junction temperature	- 55 to + 150 150	°C	
T_L	Maximum lead temperature for soldering during 10s	260	°C	

Note 1 : Pulse waveform :

$$\begin{array}{lll} 10/1000\mu s & t_r=10\mu s & t_p=1000\mu s \\ 5/310\mu s & t_r=5\mu s & t_p=310\mu s \\ 2/10\mu s & t_r=2\mu s & t_p=10\mu s \end{array}$$



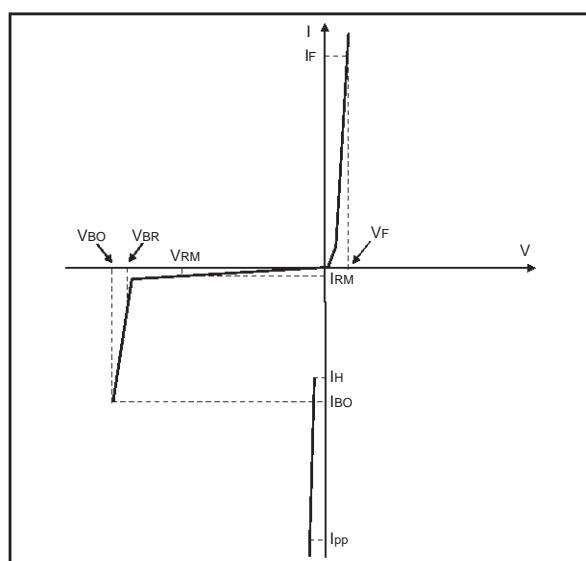
THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction to ambient	170	°C/W

ELECTRICAL CHARACTERISTICS

($T_{amb} = 25^\circ C$)

Symbol	Parameter
V_{RM}	Stand-off voltage
I_{RM}	Leakage current at stand-off voltage
V_{BR}	Breakdown voltage
V_{BO}	Breakover voltage
I_H	Holding current
V_F	Forward voltage drop
V_{FP}	Peak forward voltage
I_{BO}	Breakover current
I_{PP}	Peak pulse current
C	Capacitance
αT	Temperature coefficient



1 - PARAMETERS RELATED TO DIODE LINE / GND

Symbol	Test conditions	Min.	Typ.	Max.	Unit
V_F	$I_F = 1 \text{ A}$ $t_p = 100 \mu\text{s}$			2	V
V_{FP}	see curve fig. 1	NA	NA	NA	V

NA : Non Available

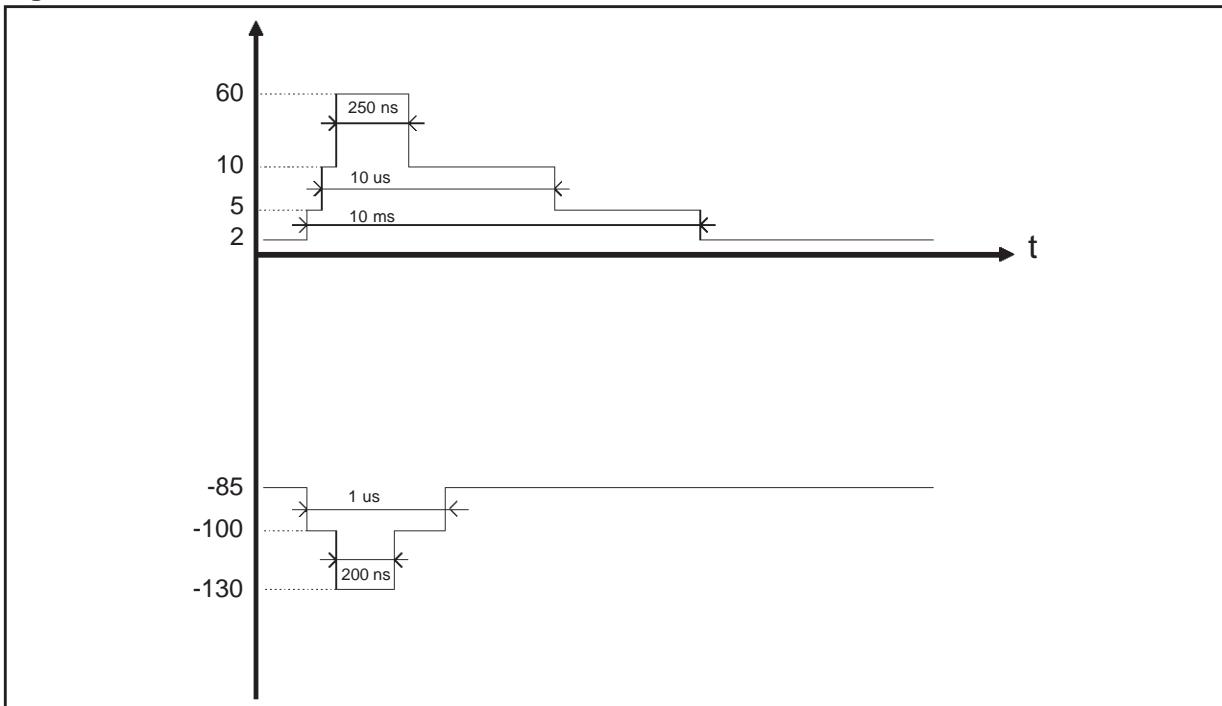
2 - PARAMETERS RELATED TO PROTECTION THYRISTOR

Symbol	Tests conditions	Min.	Typ.	Max.	Unit
V_{BR}	$I_R = 1 \text{ mA}$	65			V
V_{BO}		68		85	V
I_{RM}	$V_{RM} = 63 \text{ V}$			100	μA
I_{BO}	$t_p = 100 \mu\text{s}$	110		450	mA
I_{BO}	$F = 50 \text{ Hz}$ $R_G = 600 \Omega$			500	mA
I_H		150			mA
αT			15		$10^{-4}/^\circ\text{C}$
C	$V_D = 100 \text{ mV}_{\text{RMS}}$ $F = 1 \text{ KHz}$			500	pF
dV/dt	Linear ramp up to 67 % of V_{BR}	5			kV / μs

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DYNAMIC CHARACTERISTICS : V_{FP} and V_{BO}

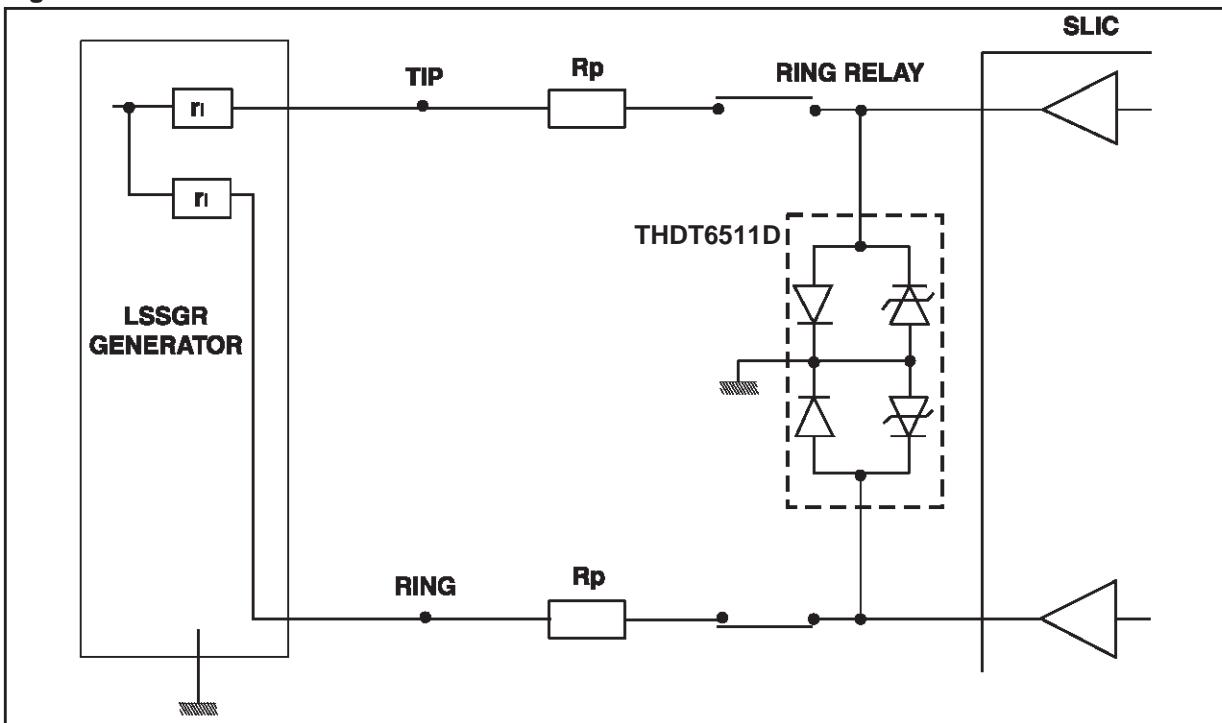
Figure 1 :



Under lightning and power crossing test, the device limits the transient voltage to the values indicated in the figure

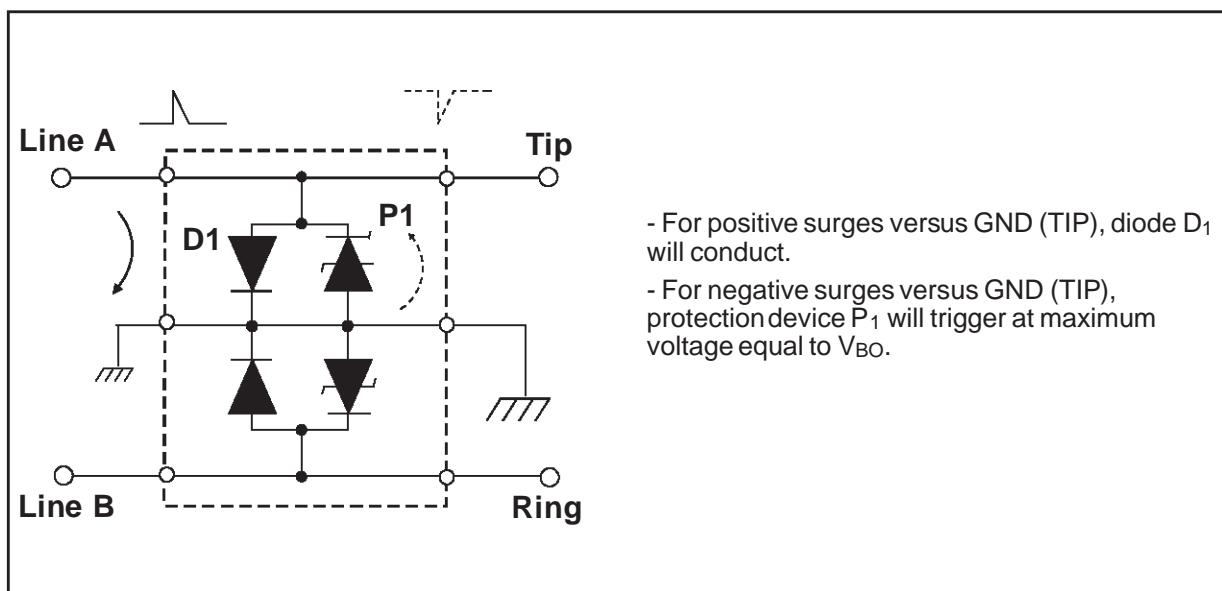
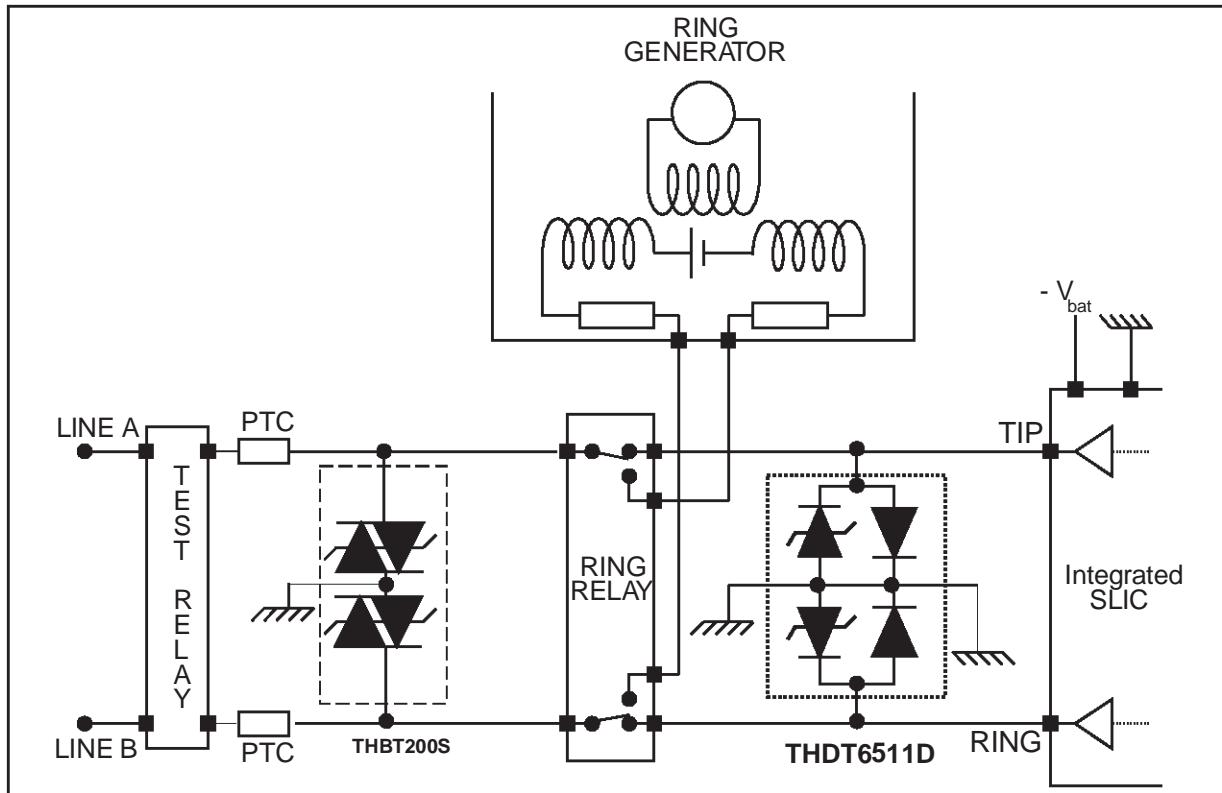
LSSGR TEST DIAGRAM

Figure 2 :



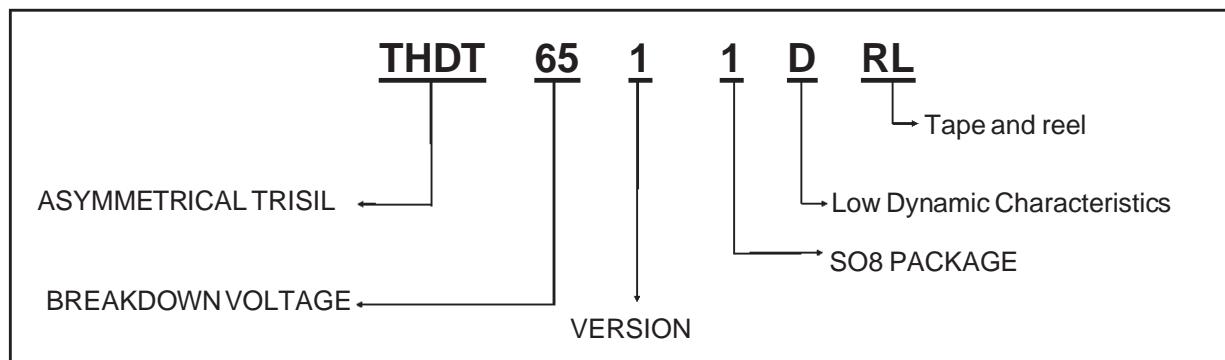
To stand the LSSGR test requirements, R_p must be $\geq 15 \Omega$

TYPICAL APPLICATION



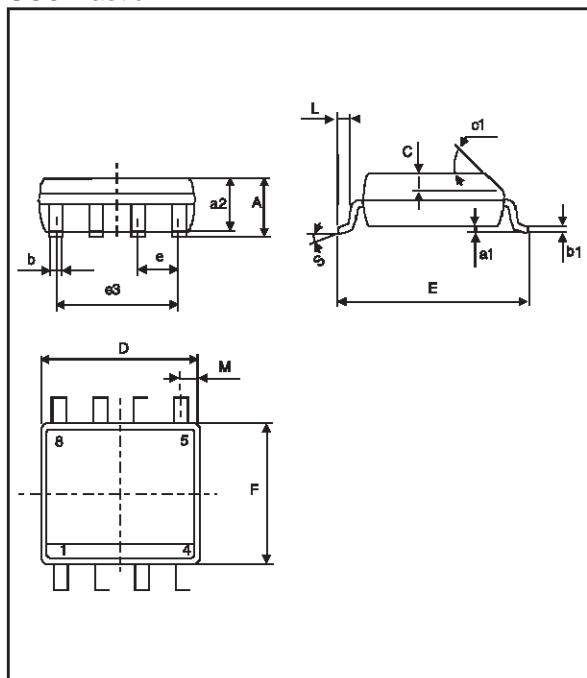
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ORDER CODE



PACKAGE MECHANICAL DATA.

SO8 Plastic



REF.	DIMENSIONS					
	Millimetres			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A			1.75			0.069
a1	0.1		0.25	0.004		0.010
a2			1.65			0.065
b	0.35		0.48	0.014		0.019
b1	0.19		0.25	0.007		0.010
C		0.50			0.020	
c1	45°(typ)					
D	4.8		5.0	0.189		0.197
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.15		0.157
L	0.4		1.27	0.016		0.050
M			0.6			0.024
S	8° (max)					

MARKING : DT651D

PACKAGING : Products supplied in antistatic tube or tape and reel.

Weight : 0.08g

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